

### General Description

The AOK20S60 has been fabricated using the advanced  $\alpha$ MOS™ high voltage process that is designed to deliver high levels of performance and robustness in switching applications.

By providing low  $R_{DS(on)}$ ,  $Q_g$  and  $E_{oss}$  along with guaranteed avalanche capability this part can be adopted quickly into new and existing offline power supply designs.

For Halogen Free add "L" suffix to part number:  
AOK20S60L

### Product Summary

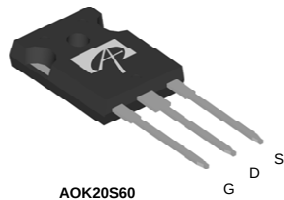
|                      |                |
|----------------------|----------------|
| $V_{DS} @ T_{j,max}$ | 700V           |
| $I_{DM}$             | 80A            |
| $R_{DS(on),max}$     | 0.199 $\Omega$ |
| $Q_{g,typ}$          | 20nC           |
| $E_{oss} @ 400V$     | 4.9 $\mu$ J    |

100% UIS Tested  
100%  $R_g$  Tested

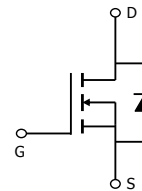


Top View

TO-247



AOK20S60



### Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

| Parameter                                                                                 | Symbol         | AOK20S60                        | Units               |
|-------------------------------------------------------------------------------------------|----------------|---------------------------------|---------------------|
| Drain-Source Voltage                                                                      | $V_{DS}$       | 600                             | V                   |
| Gate-Source Voltage                                                                       | $V_{GS}$       | $\pm 30$                        | V                   |
| Continuous Drain Current                                                                  | $I_D$          | $T_C=25^\circ\text{C}$          | A                   |
|                                                                                           |                | $T_C=100^\circ\text{C}$         |                     |
| Pulsed Drain Current <sup>C</sup>                                                         | $I_{DM}$       | 80                              | A                   |
| Avalanche Current <sup>C</sup>                                                            | $I_{AR}$       | 3.4                             | A                   |
| Repetitive avalanche energy <sup>C</sup>                                                  | $E_{AR}$       | 23                              | mJ                  |
| Single pulsed avalanche energy <sup>G</sup>                                               | $E_{AS}$       | 188                             | mJ                  |
| Power Dissipation <sup>B</sup>                                                            | $P_D$          | $T_C=25^\circ\text{C}$          | W                   |
|                                                                                           |                | Derate above $25^\circ\text{C}$ | W/ $^\circ\text{C}$ |
| MOSFET dv/dt ruggedness                                                                   | dv/dt          | 100                             | V/ns                |
| Peak diode recovery dv/dt <sup>H</sup>                                                    |                | 20                              |                     |
| Junction and Storage Temperature Range                                                    | $T_J, T_{STG}$ | -55 to 150                      | $^\circ\text{C}$    |
| Maximum lead temperature for soldering purpose, 1/8" from case for 5 seconds <sup>J</sup> | $T_L$          | 300                             | $^\circ\text{C}$    |

### Thermal Characteristics

| Parameter                                  | Symbol          | AOK20S60 | Units              |
|--------------------------------------------|-----------------|----------|--------------------|
| Maximum Junction-to-Ambient <sup>A,D</sup> | $R_{\theta JA}$ | 40       | $^\circ\text{C/W}$ |
| Maximum Case-to-sink <sup>A</sup>          | $R_{\theta CS}$ | 0.5      | $^\circ\text{C/W}$ |
| Maximum Junction-to-Case                   | $R_{\theta JC}$ | 0.47     | $^\circ\text{C/W}$ |

**Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)**

| Symbol                      | Parameter                                                 | Conditions                                                                               | Min | Typ   | Max   | Units |
|-----------------------------|-----------------------------------------------------------|------------------------------------------------------------------------------------------|-----|-------|-------|-------|
| <b>STATIC PARAMETERS</b>    |                                                           |                                                                                          |     |       |       |       |
| BV <sub>DSS</sub>           | Drain-Source Breakdown Voltage                            | I <sub>D</sub> =250μA, V <sub>GS</sub> =0V, T <sub>J</sub> =25°C                         | 600 | -     | -     | V     |
|                             |                                                           | I <sub>D</sub> =250μA, V <sub>GS</sub> =0V, T <sub>J</sub> =150°C                        | 650 | 700   | -     |       |
| I <sub>DSS</sub>            | Zero Gate Voltage Drain Current                           | V <sub>DS</sub> =600V, V <sub>GS</sub> =0V                                               | -   | -     | 1     | μA    |
|                             |                                                           | V <sub>DS</sub> =480V, T <sub>J</sub> =150°C                                             | -   | 10    | -     |       |
| I <sub>GSS</sub>            | Gate-Body leakage current                                 | V <sub>DS</sub> =0V, V <sub>GS</sub> =±30V                                               | -   | -     | ±100  | nA    |
| V <sub>GS(th)</sub>         | Gate Threshold Voltage                                    | V <sub>DS</sub> =5V, I <sub>D</sub> =250μA                                               | 2.8 | 3.4   | 4.1   | V     |
| R <sub>DS(on)</sub>         | Static Drain-Source On-Resistance                         | V <sub>GS</sub> =10V, I <sub>D</sub> =10A, T <sub>J</sub> =25°C                          | -   | 0.18  | 0.199 | Ω     |
|                             |                                                           | V <sub>GS</sub> =10V, I <sub>D</sub> =10A, T <sub>J</sub> =150°C                         | -   | 0.48  | 0.53  | Ω     |
| V <sub>SD</sub>             | Diode Forward Voltage                                     | I <sub>S</sub> =10A, V <sub>GS</sub> =0V, T <sub>J</sub> =25°C                           | -   | 0.84  | -     | V     |
| I <sub>S</sub>              | Maximum Body-Diode Continuous Current                     |                                                                                          | -   | -     | 20    | A     |
| I <sub>SM</sub>             | Maximum Body-Diode Pulsed Current <sup>C</sup>            |                                                                                          | -   | -     | 80    | A     |
| <b>DYNAMIC PARAMETERS</b>   |                                                           |                                                                                          |     |       |       |       |
| C <sub>iss</sub>            | Input Capacitance                                         | V <sub>GS</sub> =0V, V <sub>DS</sub> =100V, f=1MHz                                       | -   | 1038  | -     | pF    |
| C <sub>oss</sub>            | Output Capacitance                                        |                                                                                          | -   | 68    | -     | pF    |
| C <sub>o(er)</sub>          | Effective output capacitance, energy related <sup>H</sup> | V <sub>GS</sub> =0V, V <sub>DS</sub> =0 to 480V, f=1MHz                                  | -   | 56.6  | -     | pF    |
| C <sub>o(tr)</sub>          | Effective output capacitance, time related <sup>I</sup>   |                                                                                          | -   | 176.5 | -     | pF    |
| C <sub>rss</sub>            | Reverse Transfer Capacitance                              | V <sub>GS</sub> =0V, V <sub>DS</sub> =100V, f=1MHz                                       | -   | 2.1   | -     | pF    |
| R <sub>g</sub>              | Gate resistance                                           | V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz                                         | -   | 9.3   | -     | Ω     |
| <b>SWITCHING PARAMETERS</b> |                                                           |                                                                                          |     |       |       |       |
| Q <sub>g</sub>              | Total Gate Charge                                         | V <sub>GS</sub> =10V, V <sub>DS</sub> =480V, I <sub>D</sub> =10A                         | -   | 19.8  | -     | nC    |
| Q <sub>gs</sub>             | Gate Source Charge                                        |                                                                                          | -   | 4.6   | -     | nC    |
| Q <sub>gd</sub>             | Gate Drain Charge                                         |                                                                                          | -   | 7.6   | -     | nC    |
| t <sub>D(on)</sub>          | Turn-On DelayTime                                         | V <sub>GS</sub> =10V, V <sub>DS</sub> =400V, I <sub>D</sub> =10A,<br>R <sub>G</sub> =25Ω | -   | 27.5  | -     | ns    |
| t <sub>r</sub>              | Turn-On Rise Time                                         |                                                                                          | -   | 32    | -     | ns    |
| t <sub>D(off)</sub>         | Turn-Off DelayTime                                        |                                                                                          | -   | 87.5  | -     | ns    |
| t <sub>f</sub>              | Turn-Off Fall Time                                        |                                                                                          | -   | 30    | -     | ns    |
| t <sub>rr</sub>             | Body Diode Reverse Recovery Time                          | I <sub>F</sub> =10A, dI/dt=100A/μs, V <sub>DS</sub> =400V                                | -   | 350   | -     | ns    |
| I <sub>rm</sub>             | Peak Reverse Recovery Current                             | I <sub>F</sub> =10A, dI/dt=100A/μs, V <sub>DS</sub> =400V                                | -   | 27    | -     | A     |
| Q <sub>rr</sub>             | Body Diode Reverse Recovery Charge                        | I <sub>F</sub> =10A, dI/dt=100A/μs, V <sub>DS</sub> =400V                                | -   | 5.7   | -     | μC    |

A. The value of R<sub>θJA</sub> is measured with the device in a still air environment with T<sub>A</sub>=25°C.

B. The power dissipation P<sub>D</sub> is based on T<sub>J(MAX)</sub>=150°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature T<sub>J(MAX)</sub>=150°C. Ratings are based on low frequency and duty cycles to keep initial T<sub>J</sub>=25°C.

D. The R<sub>θJA</sub> is the sum of the thermal impedance from junction to case R<sub>θJC</sub> and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300 μs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T<sub>J(MAX)</sub>=150°C. The SOA curve provides a single pulse rating.

G. L=60mH, I<sub>AS</sub>=2.5A, V<sub>DD</sub>=150V, Starting T<sub>J</sub>=25°C

H. C<sub>o(er)</sub> is a fixed capacitance that gives the same stored energy as C<sub>oss</sub> while V<sub>DS</sub> is rising from 0 to 80% V<sub>(BR)DSS</sub>.

I. C<sub>o(tr)</sub> is a fixed capacitance that gives the same charging time as C<sub>oss</sub> while V<sub>DS</sub> is rising from 0 to 80% V<sub>(BR)DSS</sub>.

J. Wavesoldering only allowed at leads.

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**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

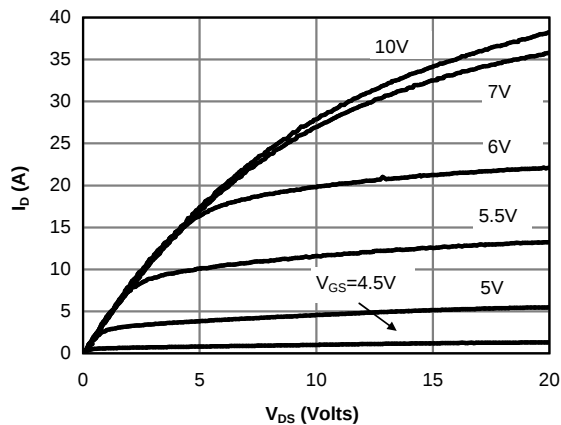


Figure 1: On-Region Characteristics@25°C

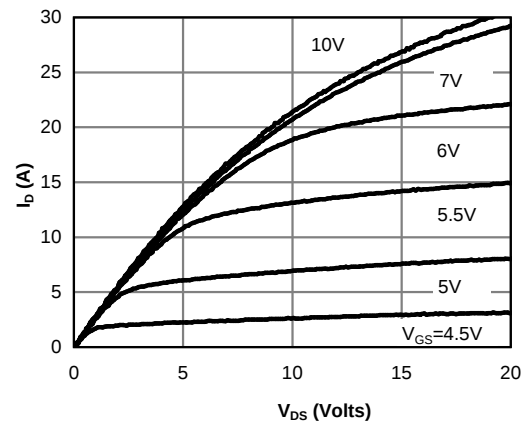


Figure 2: On-Region Characteristics@125°C

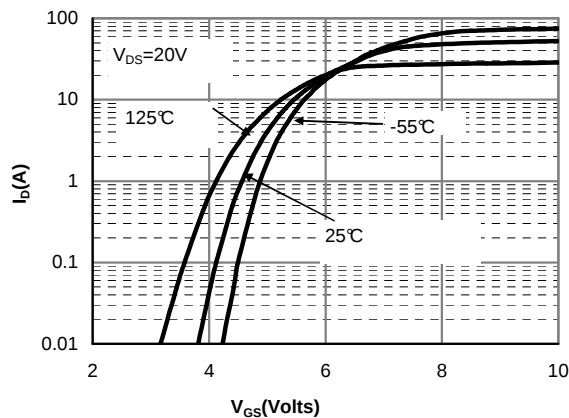


Figure 3: Transfer Characteristics

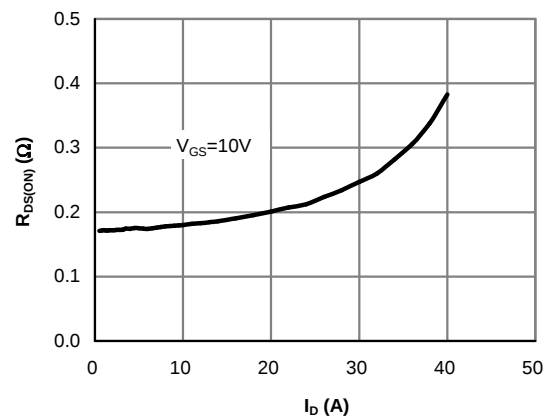


Figure 4: On-Resistance vs. Drain Current and Gate Voltage

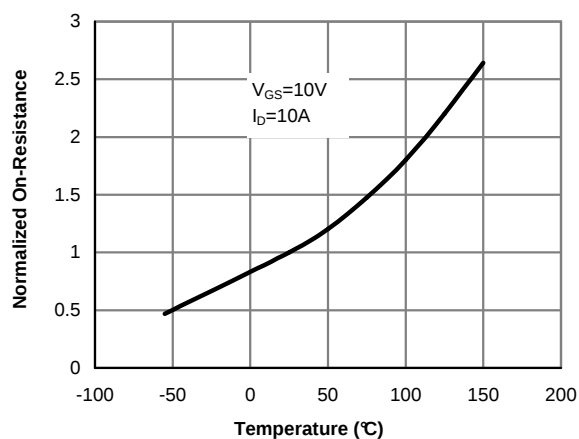


Figure 5: On-Resistance vs. Junction Temperature

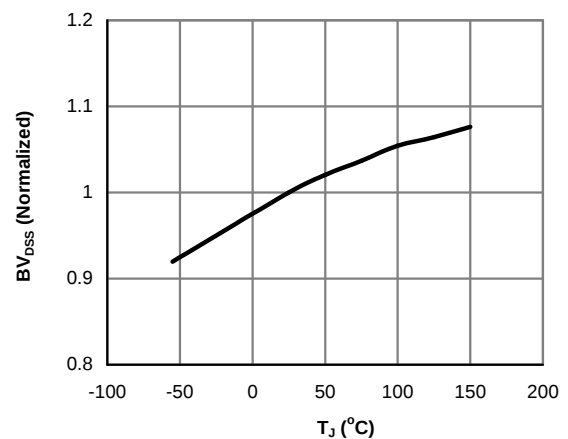
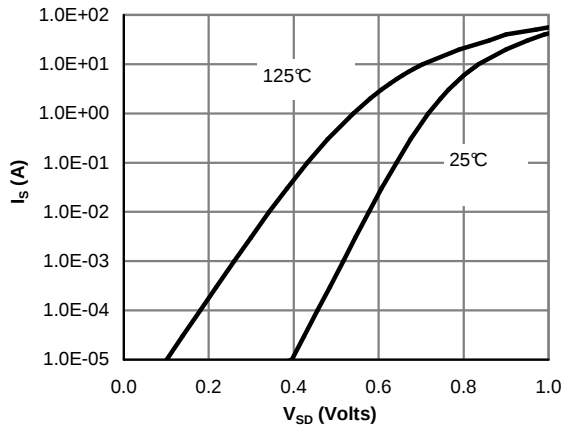
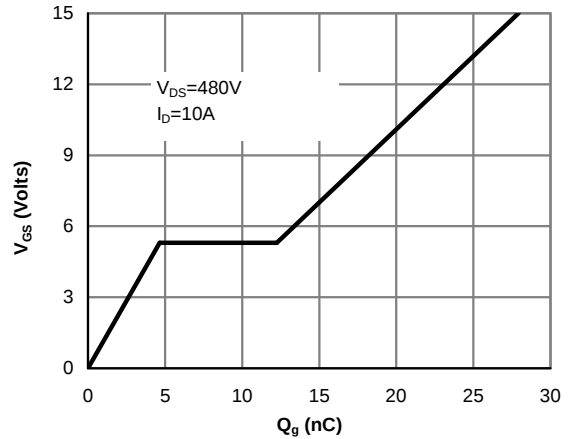


Figure 6: Break Down vs. Junction Temperature

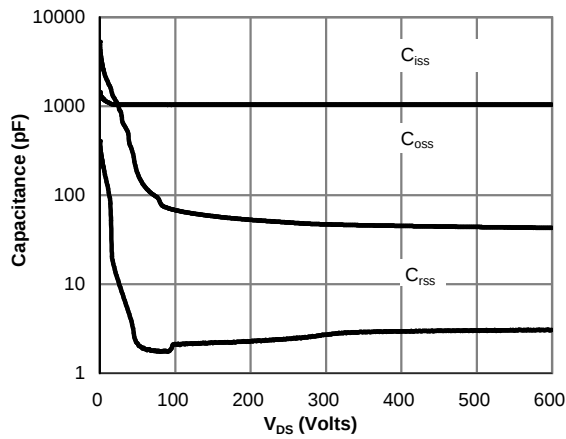
**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**



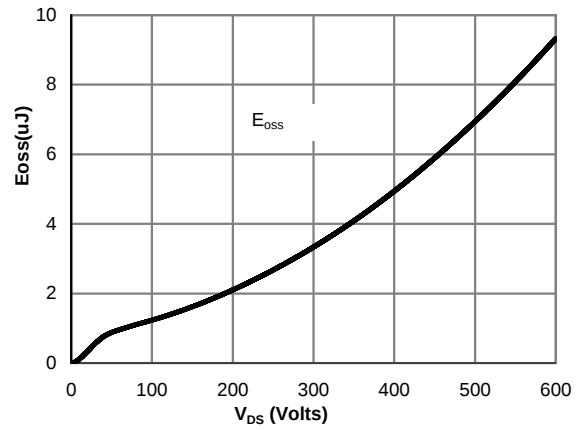
**Figure 7: Body-Diode Characteristics (Note E)**



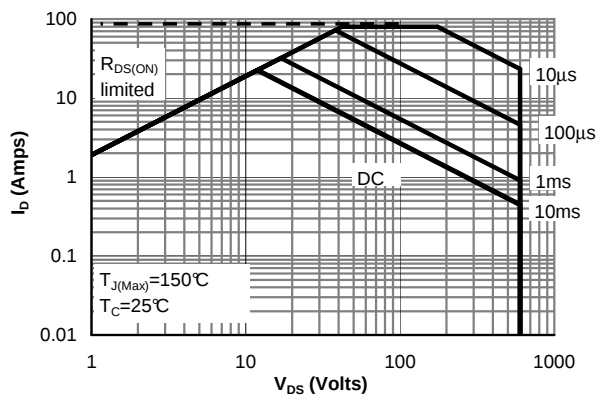
**Figure 8: Gate-Charge Characteristics**



**Figure 9: Capacitance Characteristics**



**Figure 10: Coss stored Energy**



**Figure 11: Maximum Forward Biased Safe Operating Area for AOK20S60 (Note F)**

**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

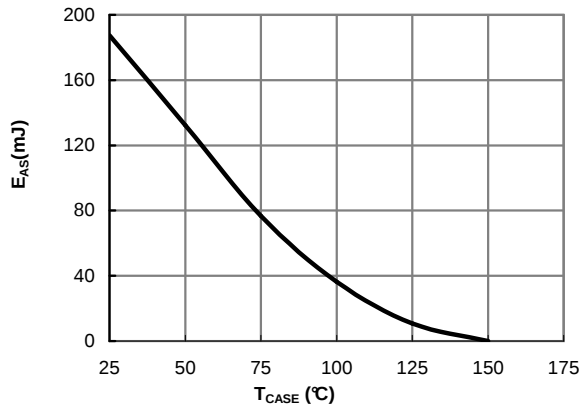


Figure 12: Avalanche energy

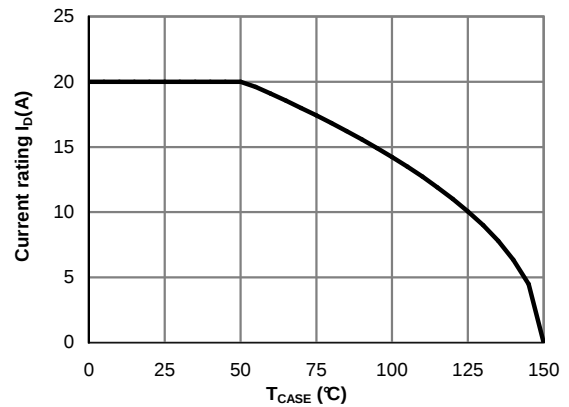


Figure 13: Current De-rating (Note B)

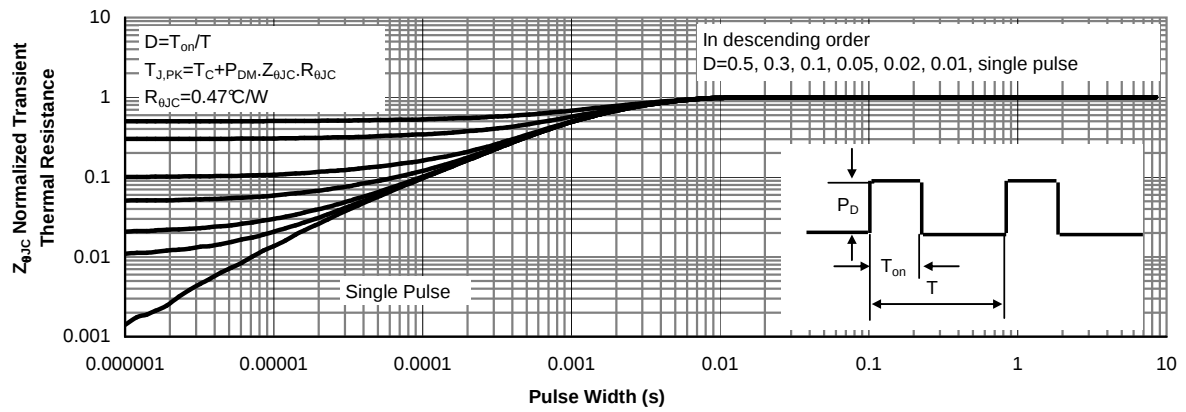
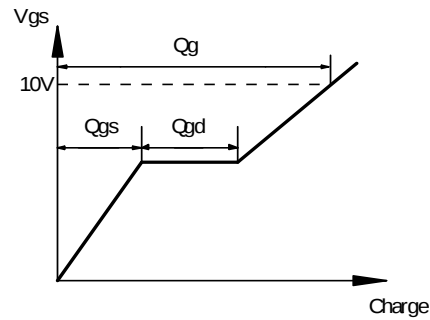
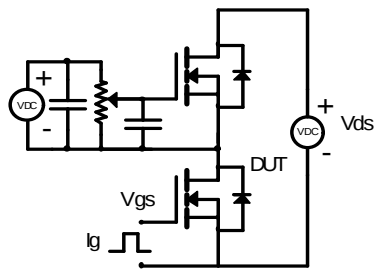
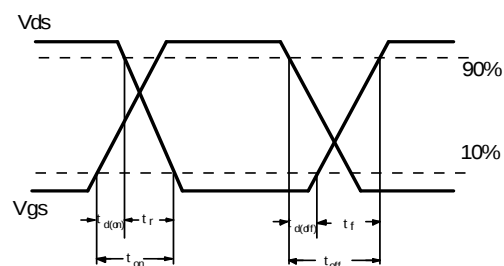
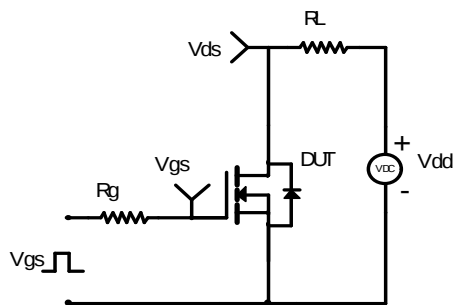


Figure 14: Normalized Maximum Transient Thermal Impedance for AOK20S60 (Note F)

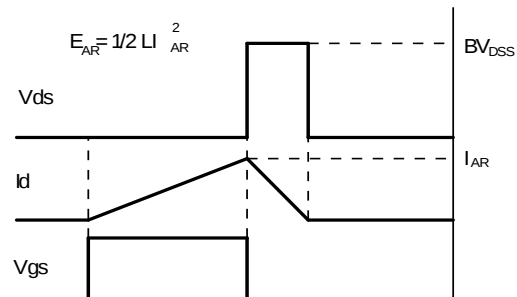
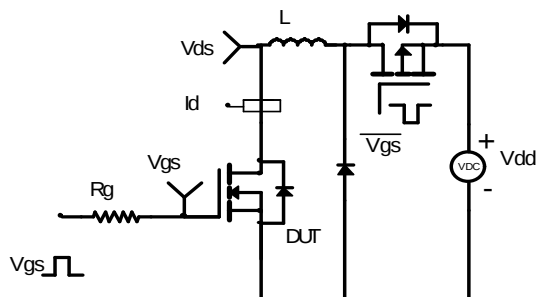
### Gate Charge Test Circuit & Waveform



## Resistive Switching Test Circuit & Waveforms



### Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



### Diode Recovery Test Circuit & Waveforms

